Interlaboratory comparison for mechanical vibration testing

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Overview

- ISO17025 requirement
- First round
- Second round
- Test sample analysis and uncertainty budget
- Test lab comparison
- Conclusions and To Do







ISO17025 Requirement

§5.9: Assuring the quality of test and calibration results

- Use of quality control procedures for monitoring the validity of test/ calibrations
- Monitoring may include, but not limited to
 - a) Use of certified materials
 - b) Participation in inter-laboratory comparisons/ proficiency testing
 - c) Replicate testing
 - d) Re-testing / re-calibration of retained items
 - e) Correlation of results for different characteristics







Third line control

ISO17025 Requirement

Proficiency testing:

comparative testing in order to assure quality of test results by application of test methods

Intra-laboratory comparison:



1st and 2nd line control *Repeatability*

Interlaboratory comparison:

3rd line control *Reproducibility*



→ No substitute for calibration !

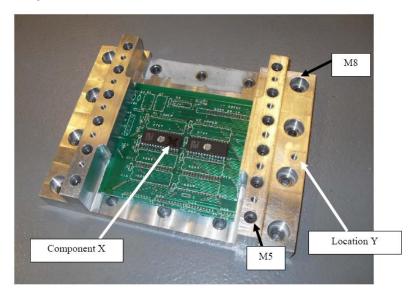


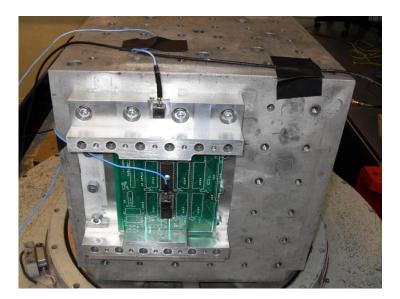




First round

• Sample:





Sample showed to be too unstable and not homogeneous







Second round

- Sample choice:
 - Needs to be:
- 1) Representative
- 2) Stable over (test)time
- 3) Homogeneous (-> identical sample for each lab)
- 4) (not too) elementary



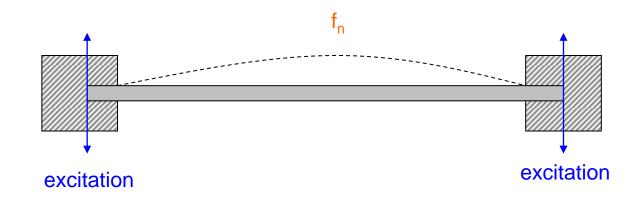




Second round

• Sample description and measurement criteria:

Considering a fixed-fixed beam structure with uniform mass distribution as SDoF system, determine f_n by application of uniaxial forced vibration





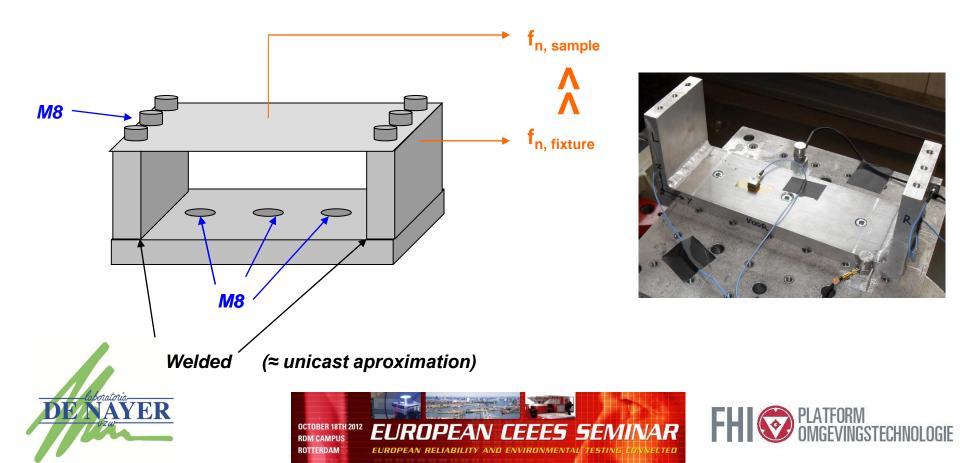




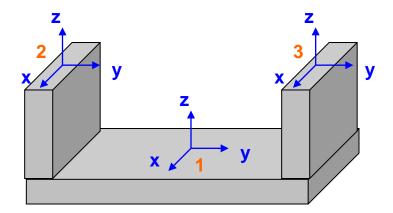
Second round

• Sample design:

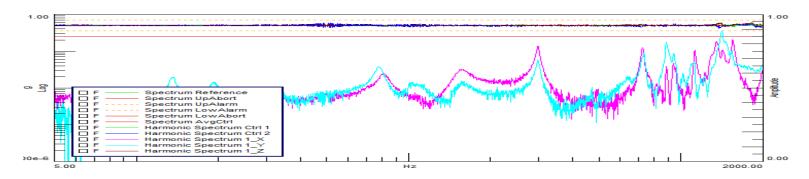
Need for rigid reference structure near fixed ends (SDoF !)



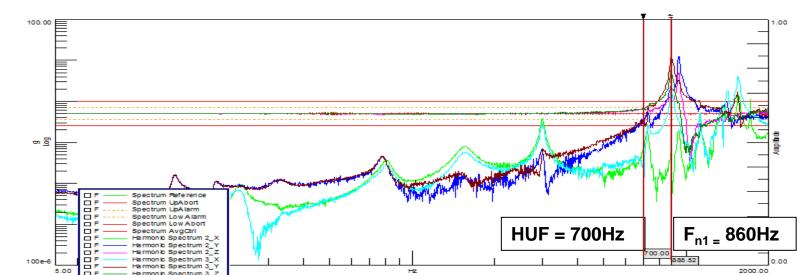
Fixture analysis



- Triax 1,2,3 with forced excitation in Z-direction
- No resonance for acc1



• First recorded resonance (Z) for acc1 and acc2 at 860Hz. Fixture ok up to 700Hz

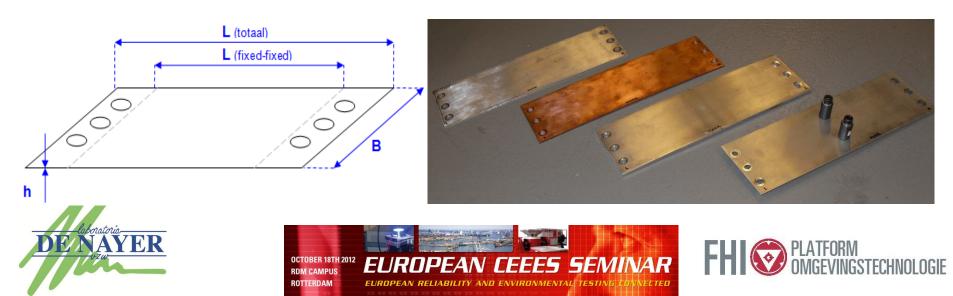


Test samples

• Different materials and dimensions (L_(fixed-fixed) : 300mm; B: 100mm)



- Thin AI with central mass (h: 1,5mm)

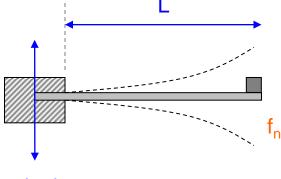


Test sample analysis - by calculation

- <u>Step 1</u>: Young's modulus by resonance measurement of cantilever
 - Cantilever setup for each plate type
 - Measurement of f_n

$$= E = \left[2\pi f_n \cdot \frac{L^2}{3.5156}\right]^2 \cdot \left[\frac{0.2235 \cdot (m_{sample}/L) + m_{accel}}{I}\right]$$

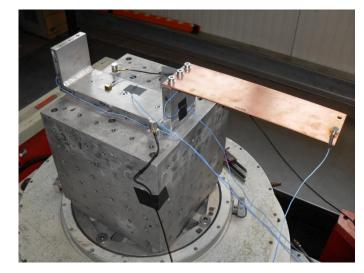
with: $I = \frac{1}{12}Bh^3$



excitation

- Results:

Sample	f _n <i>(Hz)</i>	E (<i>kN/mm²</i>)
Thin Al	11,44	59,8
Cu	18,91	124,9
Thick Al	40,89	56,4



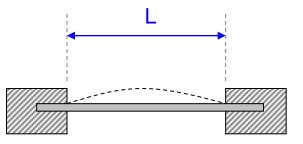
Test sample analysis - by calculation

• <u>Step 2</u>: calculation of first f_n for fixed-fixed setup

$$f_n = \frac{1}{2\pi} \left[\frac{22.373}{L^2} \right] \sqrt{\frac{EI}{m_{sample}/L}}$$

Calculation results:

Sample	f _{n, calc} <i>(Hz)</i>
Thin Al	79,17
Cu	128,72
Thick Al	273,14



f_n





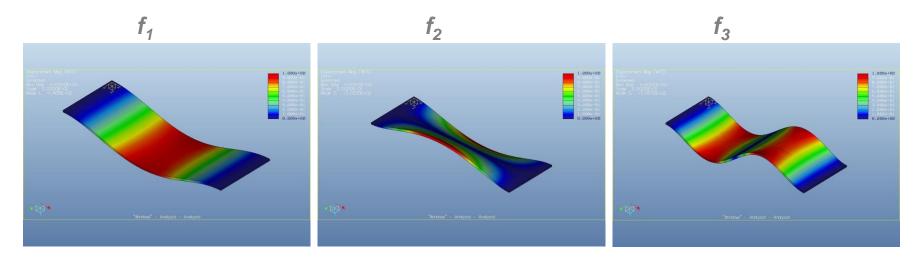


Test sample analysis - by FEM

• FEM of first bending modes

Sample	f _{n,1, calc} <i>(Hz)</i>	f _{n,1, FEM} (Hz)
Thin Al	79,17	81,7
Cu	128,72	133,4
Thick Al	273,14	272,4

- Are NOT "holy" values, But are used for verification -Remark: (max) 3,5% deviation between $\rm f_{n,calc}$ and $\rm f_{n,FEM}$



Test sample uncertainty budget

- Contribution 1: Intermediairy precision:
 - Examination of effect due to random events in same lab
 - Possible variables: setup, engineer, accelerometers (positions), torque [20-25Nm]

Results:

worst case = thin AI plate

n	freq (Hz)
1	86,94
2	85,04
3	84,8
4	84,57
5	86,07
6	85,51
7	86,7
8	85,04
9	84,1

σ ₁	= 0,9694
RSD	= 1,14%
k	= 2,3 (n = 9) (Gaussian distribution)
U	= 2,3 . RSD
	= <u>+</u> 2,28% within 95% interval
	34.1% 34.1%
	0.1% 13.6% 13.6% 13.6%

%

Test sample uncertainty budget

• Contribution 2: Stability over time:

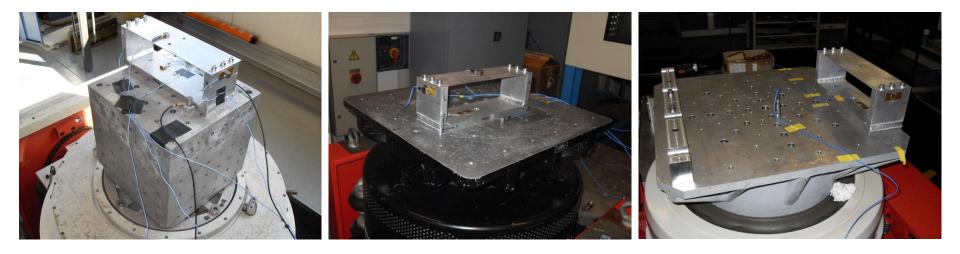
- Examination of effect due to frequency shift over time
- Recorded with tracked sine dwell $@f_n$ with time recording over 10' (3x)



BUT: no specific trend (_____ = linear trend analysis) data spreading assumed to be due to dwell algorythm => contribution 2 will not be taken into account

Test lab comparison

- Measurement results comparison for 3 laboratories (# participants limited)
- Sine sweep 0,5g (sweep up), 5Hz 700Hz, 1 Oct/min



Lab1 LDS V964LS Lab2 RMS SW6507 Lab3 LDS V850



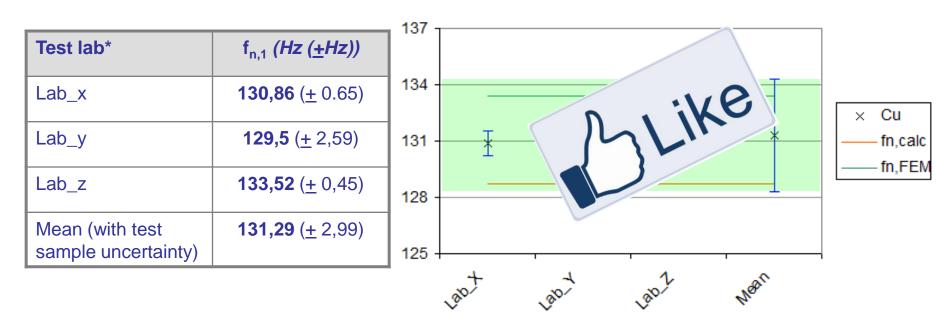




Test lab comparison - results

• Sample 2: Cu

*: x,y,z not related to pictures on previous slide







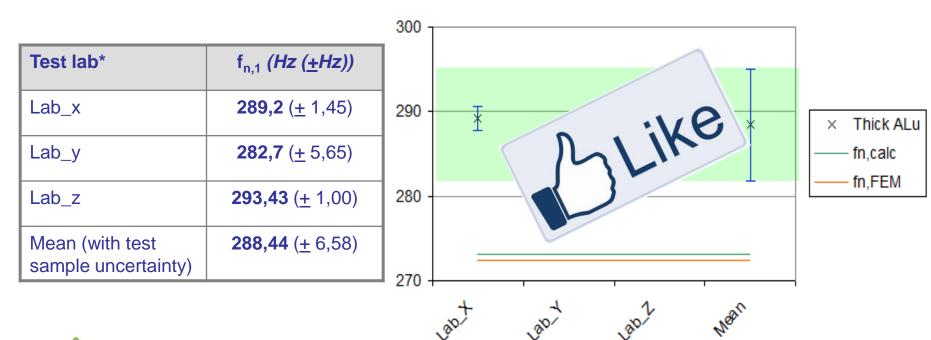
PI ATFORM

OGIF

Test lab comparison - results

• Sample 3: Thick Al

*: x,y,z not related to pictures on previous slide







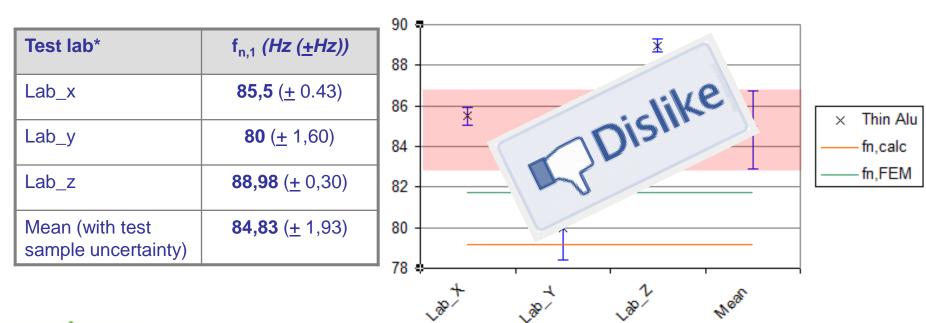
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Test lab comparison - results

• Sample 1: Thin Al

*: x,y,z not related to pictures on previous slide







PIATFORM

OGIF

Conclusions

- Comparative results are correlating for 2 out of 3 samples
 => Sample 1 needs further evaluation
- Differences are systematic , not random

To Do

- Further analysis of sample 1
- Theoretical analysis of sample 4





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Questions..?





